**3GPP TSG-RAN WG4 Meeting #** **103-e *R4-221xxxx***

**Electronic Meeting, May 9-20, 2022**

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| *CR-Form-v12.2* |
| **CHANGE REQUEST** |
|  |
|  | **38.113** | **CR** |  | **rev** |  | **Current version:** | **15.15.0** |  |
|  |
| *For* [***HE******LP***](http://www.3gpp.org/3G_Specs/CRs.htm#_blank)*on using this form: comprehensive instructions can be found at* [*http://www.3gpp.org/Change-Requests*](http://www.3gpp.org/Change-Requests)*.* |
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| --- | --- | --- | --- | --- | --- | --- | --- | --- |
| ***Proposed change affects:*** | UICC apps |  | ME |  | Radio Access Network | **X** | Core Network |  |

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|  |
| ***Title:***  | Big CR for TS 38.113 Maintenance |
|  |  |
| ***Source to WG:*** | ZTE |
| ***Source to TSG:*** | R4 |
|  |  |
| ***Work item code:*** | NR\_newRAT-Core |  | ***Date:*** | 2022-05-23 |
|  |  |  |  |  |
| ***Category:*** | **F** |  | ***Release:*** | Rel-15 |
|  | *Use one of the following categories:****F*** *(correction)****A*** *(mirror corresponding to a change in an earlier release)****B*** *(addition of feature),* ***C*** *(functional modification of feature)****D*** *(editorial modification)*Detailed explanations of the above categories canbe found in 3GPP [TR 21.900](http://www.3gpp.org/ftp/Specs/html-info/21900.htm). | *Use one of the following releases:Rel-8 (Release 8)Rel-9 (Release 9)Rel-10 (Release 10)Rel-11 (Release 11)…Rel-16 (Release 16)Rel-17 (Release 17)Rel-18 (Release 18)Rel-19 (Release 19)* |
|  |  |
| ***Reason for change:*** | This CR contains the following draft CR endorsed in RAN4#103-e(1) R4-2211181 |
|  |  |
| ***Summary of change:*** | (1) The highest test frequency of radiated spurious emission for band n46 and n96 is proposed to be 26GHz.(2) The maximum MU value of BS EMC specifications above 12.75GHz (up to 26GHz) is proposed to be 6dB (<=1m) and 9dB (>1m). |
|  |  |
| ***Consequences if not approved:*** | There is no specific instruction for the maximum MU value of radiated emission above 12.75 GHz (up to 26GHz). |
|  |  |
| ***Clauses affected:*** | 2, 8.2.1.3, 8.2.1.4 |
|  |  |
|  | **Y** | **N** |  |  |
| ***Other specs*** |  | **X** |  Other core specifications  | TS/TR ... CR ...  |
| ***affected:*** |  | **X** |  Test specifications | TS/TR ... CR ...  |
| ***(show related CRs)*** |  | **X** |  O&M Specifications | TS/TR ... CR ...  |
|  |  |
| ***Other comments:*** |  |
|  |  |
| ***This CR's revision history:*** |  |

**--------------Start of text changes -------------**

# 2 References

The following documents contain provisions which, through reference in this text, constitute provisions of the present document.

- References are either specific (identified by date of publication, edition number, version number, etc.) or non‑specific.

- For a specific reference, subsequent revisions do not apply.

- For a non-specific reference, the latest version applies. In the case of a reference to a 3GPP document (including a GSM document), a non-specific reference implicitly refers to the latest version of that document *in the same Release as the present document*.

[1] 3GPP TR 21.905: "Vocabulary for 3GPP Specifications".

[2] 3GPP TS 38.104: "NR; Base Station (BS) radio transmission and reception".

[3] 3GPP TS 38.141-1: "NR; Base Station (BS) conformance testing Part 1: Conducted conformance testing".

[4] 3GPP TS 38.141-2: "NR; Base Station (BS) conformance testing Part 2: Radiated conformance testing".

[5] 3GPP TS 37.113: "E-UTRA, UTRA and GSM/EDGE; Multi-Standard Radio (MSR) Base Station (BS) Electromagnetic Compatibility (EMC)".

[6] 3GPP TS 37.114: "Active Antenna System (AAS) Base Station (BS) Electromagnetic Compatibility (EMC)".

[7] IEC 61000-6-1: "Electromagnetic compatibility (EMC) - Part 6-1: Generic standards - Immunity for residential, commercial and light-industrial environments".

[8] IEC 61000-6-3: "Electromagnetic compatibility (EMC) - Part 6-3: Generic standards - Emission standard for residential, commercial and light-industrial environments".

[9] IEC 60050-161: "International Electrotechnical Vocabulary (IEV) - Part 161: Electromagnetic compatibility".

[10] void

[11] CISPR 32: "Electromagnetic compatibility of multimedia equipment - Emission requirements".

[12] void

[13] IEC 61000-3-2: "Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)".

[14] IEC 61000-3-12: "Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage system with input current >16 A and ≤ 75 A per phase".

[15] IEC 61000-3-3: "Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection".

[16] IEC 61000-3-11: "Electromagnetic compatibility (EMC) - Part 3-11: Limits – Limitation of voltage changes, voltage fluctuations and flicker in low-voltage supply systems - Equipment with rated current ≤ 75 A and subject to conditional connections".

[17] IEC 61000-4-2: "Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test".

[18] IEC 61000-4-3: "Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test".

[19] IEC 61000-4-4: "Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test".

[20] IEC 61000-4-5: "Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test".

[21] IEC 61000-4-6: "Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio frequency fields".

[22] IEC 61000-4-11: "Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests".

[23] ETSI EN 301 489-1: "ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU and the essential requirements of article 6 of Directive 2014/30/EU".

[24] Recommendation ITU-R SM.329-12: "Unwanted emissions in the spurious domain".

[25] 3GPP TS 37.105: "Active Antenna System (AAS) Base Station (BS) transmission and reception".

[26] Recommendation ITU-R SM.1539-1: "Variation of the boundary between the out-of-band and spurious domains required for the application of Recommendations ITU-R SM.1541 and ITU-R SM.329".

[27] 3GPP TS 38.101-4: "NR; User Equipment (UE) radio transmission and reception; Part 4: Performance requirements".

[28] ETSI EN 301 489-50: "Electromagnetic compatibility (EMC) standard for radio equipment and services; Part 50: Specific conditions for cellular communication base station (BS), repeater and ancillary equipment; Harmonised standard covering the essential requirements of article 3.1(b) of the Directive 2014/53/EU".

[29] IEC 61000-4-21: "Electromagnetic compatibility (EMC) - Part 4-21: Testing and measurement techniques - Reverberation chamber test methods".

[30] CISPR 16-1-4: 2019-01: "Specification for radio disturbance and immunity measuring apparatus and methods – Part 1-4: Radio disturbance and immunity measuring apparatus – Antennas and test sites for radiated disturbance measurements"

[31] CISPR 16-4-2: " Specification for radio disturbance and immunity measuring apparatus and methods - Part 4-2: Uncertainties, statistics and limit modelling - Measurement instrumentation uncertainty, Amendment 2"

[32] ETSI TR 100 028-1: "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics, part 1"

**--------------Next text changes -------------**

#### 8.2.1.3 Limits

The frequency boundary and reference bandwidths for the detailed transitions of the limits between the requirements for out of band emissions and spurious emissions are based on ITU-R Recommendations SM.329 [24] and SM.1539 [26].

The *BS type 1-C* and *BS type 1-H* shall meet the limits below:

Table 8.2.1.3-1: Limits for radiated emissions from BS

|  |  |  |  |  |  |
| --- | --- | --- | --- | --- | --- |
| Frequency range | e.r.p. (dBm) | Field strength at 3 m (dBµV/m)(NOTE 4) | Field strength at 10 m (dBµV/m)(NOTE 4) | Reference bandwidth | Notes |
| 30 MHz ≤ f < 1000 MHz | -36 | 65.4 (NOTE 5) | 54.9 (NOTE 5) | 100 kHz |  |
| 1 GHz ≤ f < 12.75 GHz | -30 | 67.4 | Not applicable | 1 MHz |  |
| 12.75 GHz ≤ f < 5th harmonic of the upper frequency edge of the DL operating band in GHz | -30 | 67.4 | Not applicable | 1 MHz | NOTE 1 |
| 12.75 GHz - 26 GHz | -30 | 67.4 | Not applicable | 1 MHz | NOTE 6 |
| FDL,low - ΔfOBUE < f < FDL,high +ΔfOBUE | Not defined | Not defined | Not defined | Not defined | NOTE 2,3 |
| NOTE 1: This frequency range applies only for operating bands for which the 5th harmonic of the upper frequency edge of the DL operating band is reaching beyond 12.75 GHz.NOTE 2: For BS capable of multi-band operation, the frequency ranges relating to the RF bandwidths of all supported *operating bands* apply.NOTE 3: ΔfOBUE is defined in clause 6.6.1 of TS 38.104 [2].NOTE 4: The field strength measurements shall be conducted on OATS or SAC for frequencies up to 1 GHz, or on FSOATS or FAR for frequencies above 1 GHz.NOTE 5: Limits for radiated emissions are translated from the e.r.p. limit of -36 dBm into the field strength limit of 61.4 dBµV/m (at 3m) or 50.9 dBµV/m (at 10m), and increased by the site gain value of 4 dB. The value of the site gain is based on ITU-R Recommendations SM.329 [24].NOTE 6: Applies only for band n46, n96 and n102. |

#### 8.2.1.4 Interpretation of the measurement results

The interpretation of the results recorded in a test report for the radiated emission measurements described in the present document shall be as follows:

- the measured value related to the corresponding limit will be used to decide whether an equipment meets the requirements of the present document;

- the value of the measurement uncertainty for the measurement of each parameter shall be included in the test report;

- the recorded value of the measurement uncertainty shall be, for each measurement, equal to or lower than the figures in table 8.2.1-4-1 for BS.

Table 8.2.1.4-1 specifies the maximum measurement uncertainty of the test system. The test system shall enable the equipment under test to be measured with an uncertainty not exceeding the specified values. All tolerances and uncertainties are absolute values, and are valid for a confidence level of 95 %, unless otherwise stated.

A confidence level of 95 % is the measurement uncertainty tolerance interval for a specific measurement that contains 95% of the performance of a population of test equipment.

Table 8.2.1.4-1: Maximum measurement uncertainty (BS)

|  |  |  |
| --- | --- | --- |
| Parameter | Uncertainty for EUT dimension ≤ 1 m(NOTE 2) | Uncertainty for EUT dimension >1 m(NOTE 2) |
| Effective radiated RF power between 30 MHz and 180 MHz | ±6 dB | ±6 dB |
| Effective radiated RF power between 180 MHz and 4 GHz | ±4 dB | ±6 dB |
| Effective radiated RF power between 4 GHz and 12,75 GHz | ±6 dB | ±9 dB (NOTE 1) |
| Effective radiated RF power between 12,75 GHz and 26 GHz | ±6 dB | ±9 dB (NOTE 1) |
| Field strength between 30 MHz and 12,75 GHz | ±6 dB | ±6 dB |
| Field strength between 12,75 GHz and 26 GHz | ±6 dB | ±6 dB |
| NOTE 1: This value may be reduced to ±6 dB when further information on the potential radiation characteristic of the EUT is available.NOTE 2: These MU values estimates and are not based on the MU budget calculations. For more background on MU derivation analyses refer to CISPR 16-4-2 [31] and ETSI TR 100 028-1 [32]. |

NOTE: If the Test System for a test is known to have a measurement uncertainty greater than that specified in table 8.2.1.4-1, this equipment can still be used, provided that an adjustment is made follows:

 Any additional uncertainty in the Test System over and above that specified in table 8.2.1.4-1 is used to tighten the test requirements, i.e. making the test harder to pass.

 This procedure will ensure that a test system not compliant with table 8.2.1.4-1 does not increase the probability of passing a EUT that would otherwise have failed a test if a test system compliant with table 8.2.1.4-1 had been used.

 **-------------End of changes -------------**